


<b>Search Notes</b> 	<b>Application/Control No.</b> 10767147	<b>Applicant(s)/Patent Under Reexamination</b> SMIT ET AL.
	<b>Examiner</b> Berhanu, Etsub D	<b>Art Unit</b> 3768

SEARCHED			
Class	Subclass	Date	Examiner
600	317, 407, 473, 476	12/10/2008	EDB

SEARCH NOTES		
Search Notes	Date	Examiner
Searched EAST (USPAT, USPGPUB)	12/10/2008	EDB
Class/subclass search and Keyword Search	12/10/2008	EDB
PALM Inventor Name Search	12/10/2008	EDB
See Attached Sheet	12/10/2008	EDB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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